



7

.

MICROCOPY RESOLUTION TEST CHART NATIONAL BUREAU OF STANDARDS-1963-A

÷

SECURITY CLASSIFICATION OF THIS PAGE (Mon Data Entered)	
REPORT DOCUMENTATION PAGE	READ INSTRUCTIONS
1. HEPORT NUMBER 2. GOVT ACCESSION NO	BEFORE CO PLETING FORM 3. RECIPIENT'S CATALOG NUMBER
55 AD-140148	
4. TITLE (and Subtitle)	5. TYPE OF REPORT & PERIOD COVERE
Structure of Silver (100) and (111) Single-Crystal	Technical Report 55
Surfaces Obtained by Chemical Polishing	6. PERFORMING ORG. REPORT NUMBER
7. AUTHOR(3)	
	B. CONTRACT OR GRANT NUMBER(*)
R.R. Adzic, M.E. Hanson, and E.B. Yeager	N00014-75-C-0953
9. PERFORMING ORGANIZATION NAME AND ADDRESS	10. PROGRAM ELEMENT. PROJECT, TASK AREA & WORK UNIT NUMBERS
Dept. of Chemistry & Case Cntr. for Electrochem. Case Western Reserve University / Sciences Cleveland, Ohio 44106	
11. CONTROLLING OFFICE NAME AND ADDRESS	12. REPORT DATE
Office of Naval Research	1 December 1983
Chemistry Program – Chemistry Code 472	13. NUMBER OF PAGES
Arlington, Virginia 22217 14. MONITORING AGENCY NAME & ADDRESS(II dillerent from Controlling Office)	
The munituring AUERUT NAME & AUGRESSIL BILLETON LITON CONTROLLING DILICE)	15. SECURITY CLASS. (of this report)
	Unclassified
	154. DECLASSIFICATION/DOWNGRADING SCHEDULE
This document has been approved for public release; 17. DISTRIBUTION STATEMENT (of the obstract entered in Block 20, If different from	n Report)
	n Report)
17. DISTRIBUTION STATEMENT (of the obstract entered in Block 20, II different from	n Report)
	n Report)
17. DISTRIBUTION STATEMENT (of the obstract entered in Block 20, II different from	APR 1 2 1984
17. DISTRIBUTION STATEMENT (of the obstract entered in Block 20, If different from 18. SUPPLEMENTARY NOTES Submitted for publication as a technical note in the	APR 1 2 1984
17. DISTRIBUTION STATEMENT (of the obstract entered in Block 20, 11 different from 18. SUPPLEMENTARY NOTES Submitted for publication as a technical note in the chemical Society.	APR 1 2 1984 APR 1 2 1984 A A A A A
17. DISTRIBUTION STATEMENT (of the obstract entered in Block 20, if different from 18. SUPPLEMENTARY NOTES Submitted for publication as a technical note in the chemical Society. 19. KEY WORDS (Continue on reverse olde if necessary and identify by block number)	APR 1 2 1984 APR 1 2 1984 A e Journal of the Electro-
 DISTRIBUTION STATEMENT (of the obstract entered in Block 20, If different from SUPPLEMENTARY NOTES Submitted for publication as a technical note in the chemical Society. KEY WORDS (Continue on reverse alde if necessary and identify by block number) single-crystal electrodes, silver, LEED, chemical points 	APR 1 2 1984 APR 1 2 1984 A e Journal of the Electro-
 17. DISTRIBUTION STATEMENT (of the obstract onlored in Block 20, 11 different from 18. SUPPLEMENTARY NOTES Submitted for publication as a technical note in the chemical Society. 19. KEY WORDS (Continue on reverse olde 11 necessary and identify by block number) single-crystal electrodes, silver, LEED, chemical point (how Energy Electron Difference of the intervence olde 11 necessary and identify by block number) In single-crystal electrochemical studies, various in 	APR 1 2 1984 APR 1 2 1984 A e Journal of the Electro- olishing
 17. DISTRIBUTION STATEMENT (of the obstract entered in Block 20, 11 different from 18. SUPPLEMENTARY NOTES Submitted for publication as a technical note in the chemical Society. 19. KEY WORDS (Continue on reverse olde 11 necessary and identify by block number) single-crystal electrodes, silver, LEED, chemical point (how Energy Electron Difference and identify by block number) In single-crystal electrochemical studies, various in electrode surfaces by mechanical polishing followed 	APR 1 2 1984 APR 1 2 1984 A a b b b c c c c c c c c c c c c c c c c
 17. DISTRIBUTION STATEMENT (of the obstract entered in Block 20, Il different from 18. SUPPLEMENTARY NOTES Submitted for publication as a technical note in the chemical Society. 19. KEY WORDS (Continue on reference side if necessary and identify by block number) single-crystal electrodes, silver, LEED, chemical point (Low Energy Electron Difficience) In single-crystal electrochemical studies, various in electrode surfaces by mechanical polishing followed further cleaning or high temperature annealing in variant. 	APR 1 2 1984 APR 1 2 1984 A a b b c c c c c c c c c c c c c c c c c
 17. DISTRIBUTION STATEMENT (of the obstract entered in Block 20, Il different from 18. SUPPLEMENTARY NOTES Submitted for publication as a technical note in the chemical Society. 19. KEY WORDS (Continue on reference side if necessary and identify by block number) single-crystal electrodes, silver, LEED, chemical point (Low Energy Electron Difficience) In single-crystal electrochemical studies, various in electrode surfaces by mechanical polishing followed further cleaning or high temperature annealing in variable, crystal surfaces is in question. The present 	APR 1 2 1984 APR 1 2 1984 A a b b c c c c c c c c c c c c c c c c c
17. DISTRIBUTION STATEMENT (of the obstreet entered in Block 20, Il different from 18. SUPPLEMENTARY NOTES Submitted for publication as a technical note in the chemical Society. 19. KEY WORDS (Continue on reverse elde II necessary and identify by block number) single-crystal electrodes, silver, LEED, chemical public $(L_{OW}) \in RERCy \in EECTPON D(FFMACT)$ In single-crystal electrochemical studies, various points electrode surfaces by mechanical polishing followed further cleaning or high temperature annealing in variable LEED vand Auger electron spectroscopy (AES) to examinisilver (111) and (100) surfaces after preparation with the surfaces of the surfaces after preparation with the surfaces of the surfaces after preparation with	APR 1 2 1984 APR 1 2 1984 A a Journal of the Electro- olishing b b cresearchers have prepared th by chemical polishing witho acuo. The quality of such t work has involved the use . The the order and purity of t ith such procedures with the
17. DISTRIBUTION STATEMENT (of the obstract onlored in Block 20, Il different from 18. SUPPLEMENTARY NOTES Submitted for publication as a technical note in the chemical Society. 19. KEY WORDS (Continue on reverse olde 11 necessary and identify by block number) single-crystal electrodes, silver, LEED, chemical public $(L_{OW} E_{DERGY} E_{EECTPOD} D_{IFFMDE} u$ In single-crystal electrochemical studies, various to electrode surfaces by mechanical polishing followed further cleaning or high temperature annealing in va single-crystal surfaces is in question. The present LEED vand Auger electron spectroscopy (AES) to examine	APR 1 2 1984 APR 1 2 1984 A a Journal of the Electro- olishing by chemical polishing without cuo. The quality of such t work has involved the use of the the order and purity of the other of the such procedures with the
17. DISTRIBUTION STATEMENT (of the obstract entered in Block 20, If different free 18. SUPPLEMENTARY NOTES Submitted for publication as a technical note in the chemical Society. 19. KEY WORDS (Continue on reverse elde If necessary and identify by block number) single-crystal electrodes, silver, LEED, chemical public $L_{ous} E_{nERCy} E_{LECTPON} D_{IFFFNC-u}$ 19. ABSTRACT (Continue on reverse elde If necessary and identify by block number) In single-crystal electrochemical studies, various in electrode surfaces by mechanical polishing followed further cleaning or high temperature annealing in variances Single-crystal surfaces is in question. The present LEED wand Auger electron spectroscopy (AES) to examining single-crystal polishing carried out in a cyanide-hydroger	APR 1 2 1984 APR 1 2 1984 A a Journal of the Electro- olishing by chemical polishing without cuo. The quality of such t work has involved the use of the the order and purity of the other of the such procedures with the
17. DISTRIBUTION STATEMENT (of the obsized entered in Block 20, 11 different from 18. SUPPLEMENTARY NOTES Submitted for publication as a technical note in the chemical Society. 19. KEY WORDS (Continue on reverse alde 11 necessary and identify by block number) single-crystal electrodes, silver, LEED, chemical public $(L_{ous} \sum_{r \in RCY} \sum_{c \in CTPOR} D_{ifTMRC} u$ 19. ABSTRACT (Continue on reverse alde 11 necessary and identify by block number) In single-crystal electrochemical studies, various is electrode surfaces by mechanical polishing followed further cleaning or high temperature annealing in variangle-crystal surfaces is in question. The present LEED and Auger electron spectroscopy (AES) to examinis silver (111) and (100) surfaces after preparation with chemical polishing carried out in a cyanide-hydroger D 1 JAN 73 1473 EDITION OF 1 NOV 65 IS OBSOLETE Unclass	APR 1 2 1984 APR 1 2 1984 A a Journal of the Electro- olishing by chemical polishing without cuo. The quality of such t work has involved the use of the the order and purity of the ith such procedures with the in peroxide solution. For both sified
17. DISTRIBUTION STATEMENT (of the obsized entered in Block 20, 11 different from 18. SUPPLEMENTARY NOTES Submitted for publication as a technical note in the chemical Society. 19. KEY WORDS (Continue on reverse alde 11 necessary and identify by block number) single-crystal electrodes, silver, LEED, chemical public $(L_{ous} \sum_{r \in RCY} \sum_{c \in CTPOR} D_{ifTMRC} u$ 19. ABSTRACT (Continue on reverse alde 11 necessary and identify by block number) In single-crystal electrochemical studies, various is electrode surfaces by mechanical polishing followed further cleaning or high temperature annealing in variangle-crystal surfaces is in question. The present LEED and Auger electron spectroscopy (AES) to examinis silver (111) and (100) surfaces after preparation with chemical polishing carried out in a cyanide-hydroger D 1 JAN 73 1473 EDITION OF 1 NOV 65 IS OBSOLETE Unclass	APR 1 2 1984 APR 1 2 1984 A e Journal of the Electro- olishing by chemical polishing without cuo. The quality of such t work has involved the use of the the order and purity of the other of the solution. For bother

}20.

surfaces the LEED patterns have surprisingly well-defined spots indicating a high two-dimensional periodicity, although not as ordered as the UHV cleaned and annealed surfaces. Highly diffuse background and weak fractional-order spots are present in the LEED pattern of the chemically polished surfaces, probably due to random and ordered impurity adsorption during transfer to the vacuum chamber. The Auger electron spectra before sputtering indicate the main impurity to be carbonaceous with no nitrogen detected. Voltammetry curves in 0.1M HF in a thin-layer cell are generally featureless over the potential range -0.1 to +0.45V vs RHE. These data indicate that chemical polishing can yield silver single-crystal surfaces of sufficient quality to produce LEED patterns but still short of the quality for UHV cleaned and annealed surfaces. OFFICE OF NAVAL RESEARCH CONTRACT NO0014-75-C-0953 PROJECT NR 359-451

Technical Report No. 55

STRUCTURE OF SILVER (100) AND (111) SINGLE-CRYSTAL SURFACES OBTAINED BY CHEMICAL POLISHING

by

R.R. Adzic, M.E. Hanson, and E.B. Yeager

Case Center for Electrochemical Sciences and The Chemistry Department Case Western Reserve University Cleveland, Ohio 44106

Submitted for publication in the Journal of the Electrochemical Society

1 December 1983

Reproduction in whole or in part is permitted for any purpose of the United States Government.



21 m t

This document has been approved for public release and sale; its distribution is unlimited.

84 04 09 018

STRUCTURE OF SILVER (100) AND (111) SINGLE-CRYSTAL SURFACES OBTAINED BY CHEMICAL POLISHING

Radoslav R. Adzic^{*#}, Michael E. Hanson⁺, and Ernest B. Yeager^{*}

Case Center for Electrochemical Sciences and the Department of Chemistry Case Western Reserve University Cleveland, Ohio 44106

*Electrochemical Society active member. *Electrochemical Society student member. *Visiting faculty member, July-August 1983, from the Institute of Electrochemistry, ICTM and Center for Multidisciplinary Studies, University of Belgrade, Belgrade, Yugoslavia. Key Words: LEED, silver single-crystals, chemical polishing.

Interest has been increasing in the investigation of electrochemical reactions on single-crystal electrode surfaces (see e.g. Ref. 1-7). Electrode processes having a pronounced dependence on the particular single-crystal surface include hydrogen adsorption (8-11), underpotential deposition of metals (4), oxidation of organic molecules (6) and oxygen reduction (7). Inadequately characterized single-crystal surfaces, however, may lead to misleading results. Atomically flat, well-ordered surfaces are needed in order to obtain meaningful data. Ultrahigh vacuum techniques such as low energy electron diffraction (LEED), Auger electron spectroscopy (AES) and X-ray photoelectron spectroscopy (XPS) can facilitate the characterization of such surfaces and verification of freedom from adsorbed impurities, but these techniques are <u>ex situ</u>. Elaborate systems (8-11) have been developed for preparing and characterizing single-crystal electrode surfaces in ultra-high vacuum and then transfering them into the electrochemical environment and vise versa under conditions designed to minimize structural changes and contamination. Experiments with these transfer techniques, however, are very timeconsuming and impose substantial restraints on the types of electrochemical systems that can be studied because of factors such as the use of completely volatilizable electrolytic solutions and thin-layer cell configurations.

Some electrochemists, including one of the authors (RA), have prepared single-crystal surfaces of metals by chemical methods and then proceeded to examine the electrochemical properties of these

-1-

surfaces. This work, however, has left unanswered the question of the quality of the single-crystal surfaces. This communication presents results which demonstrate that chemical polishing in the instance of silver single-crystal electrodes can yield ordered (100) and (111) surfaces, as judged by LEED.

Single-crystals of Ag, 99.99% pure, were obtained from Metal Crystals Ltd., Cambridge, England. They were oriented to better than 1°, mechanically polished by standard metallographic techniques with diamond paste, gradually decreasing the size of the grit to 1 micron. The crystals were further polished chemically, using procedures similar to those already reported (12). An aqueous solution of 30 volume percent of H_2O_2 and a solution of 21.5 g/l of NaCN were mixed in a 1:1 ratio for polishing the Ag(111) single-crystal surface. For the Ag(100) face, a lower concentration of 20 volume percent of H_2O_2 was used. The crystals were held for 5 s in these solutions, during which time vigorous gas evolution occured. They were taken out, held in air for 3 s and transfered into a solution of 37.5 g/l NaCN, where gas evolution ceased. After washing, the procedure was repeated several times, in most instances in a fresh solution of H_2O_2 and NaCN until a highly reflecting surface was obtained. The electrode surface was then thoroughly washed in pure water. The surface obtained in this way was protected by a drop of pure water and transfered into the UHV preparation chamber of the LEED-AES-XPS system, which has been described in prior publications (8,9). The water drop was then volatilized during the pump down.

-2-

Figure la shows the LEED pattern from the Ag(111) surface immediately after introduction into the UHV chamber at 10^{-10} Torr. This LEED pattern was obtained without cleaning the surface in the vacuum chamber in any way. Neither argon-ion sputtering nor thermal annealing was used. Figure 1b shows the LEED pattern of chemically polished Ag(111) after a single sputtering with an argon-ion gun (Varian model 981-2043) for three min at 1.5 kV and subsequent radiative thermal annealing at approx. 600°C. The crystal reached this temperature in approximately 5 minutes and was allowed to cool to room temperature, which required about 20 minutes in vacuum. Analogously, Figures 2a and 2b show LEED patterns of chemically polished Ag(100) before and after, respectively, UHV sputtering and annealing.

For both the (111) and (100) crystal faces before UHV sputter cleaning, highly diffuse background and weak fractional-order spots are present in the LEED pattern, probably due to random and ordered impurity adsorption during transfer to the vacuum chamber. Auger electron spectra before sputtering indicate the main impurity to be carbonaceous. No nitrogen was detected in the AES, indicating no substantial amount of CN⁻ remained on the surface. The LEED spots are surprisingly well-defined, indicating a high two-dimensional periodicity, although not as ordered as the UHV cleaned and annealed surfaces. Voltammetry curves were also obtained in 0.1M HF in a thin-layer cell using a special transfer technique (8,9). Over the potential range -0.1 to 0.45V vs RHE voltammetry curves were generally featureless.

-3-

These data demonstrate that chemical polishing can yield silver single-crystal surfaces of high enough quality to produce LEED patterns. This is of great importance for studies of these surfaces outside UHV systems.

ACKNOWLEDGEMENTS

This research has been supported by the Office of Naval Research and the Department of Energy. Grants have also been received for equipment from General Motors and Union Carbide Corporation.

REFERENCES

- "Surface Physics of Materials", Vol. I, J.M. Blakely, ed., Academic Press, N.Y. (1975).
- 2. G. Somorjai, "Principles of Surface Chemistry", Prentice-Hall Inc., Englewood Cliffs, N.J. (1972).
- 3. A. Hamelin, T. Vitanov, E. Sevastyanov and A. Popov, J. Electroanal. Chem. Interfacial Electrochem., <u>145</u>, 225 (1983).
- 4. K. Juttner and J.W. Lorenz, Z. Phys. Chem., N.F., <u>122</u>, 163 (1980).
- 5. R.R. Adzic, A.V. Tripkovic and W.E. O'Grady, Nature, <u>296</u>, 137 (1982).
- 6. J. Clavilier, R. Parsons, R. Durand, C. Lamy and J.M. Leger, J. Electroanal. Chem. Interfacial Electrochem., <u>124</u>, 321 (1981).
- 7. R.R. Adzic and N.M. Markovic, ibid., <u>138</u>, 443 (1982).
- 8. A. Homa, E. Yeager and B.D. Cahan, J. Electroanal. Chem. Interfacial Electrochem., <u>150</u>, 181 (1983).
- 9. A. Homa, Ph.D. Thesis, Case Western Reserve University (1981).
- 10. A.T. Hubbard, R.M. Ishikawa and J. Katekaru, J. Electroanal. Chem. Interfacial Electrochem., <u>86</u>, 271 (1978).
- 11. P.N. Ross Jr., This Journal, <u>126</u>,1 (1979).

-4-



Figure 1a. LEED pattern of chemically polished Ag(111) immediately after introduction to the vacuum chamber (no sputtering or thermal annealing). Primary beam energy = 47 eV. Exposure time = 3 min. F-stop = 1.4, Kodak Panatomic X film for all exposures.



Figure 2a. LEED pattern of chemically polished Ag(100) immediately after introduction to the vacuum chamber (no sputtering or thermal annealing). Curvature of the pattern is due to the sample protruding inside the radius of the screen because of its unusually large size for the system. Primary beam energy = 48 eV. Exposure time = 3 min.



Figure 1b. Same as Figure 1a after sputtering at 1.5 kV for 3 min. and thermally annealing at 600° C. Primary beam energy = 45 eV. Exposure time = 30 s.



Figure 2b. Same as Figure 2a after sputtering at 1.5 kV for 3 min. and thermally annealing at 600° C. Primary beam energy = 60 eV. Exposure time = 30 s.

